SN54HCT573 . . . J OR W PACKAGE SN74HCT573 . . . DB, DW, N, NS, OR PW PACKAGE

(TOP VIEW)

SCLS176E - MARCH 1984 - REVISED JULY 2003

- Operating Voltage Range of 4.5 V to 5.5 V
- High-Current 3-State Outputs Drive Bus Lines Directly or Up To 15 LSTTL Loads
- Low Power Consumption, 80-µA Max I_{CC}
- Typical t_{pd} = 21 ns
- ±6-mA Output Drive at 5 V
- Low Input Current of 1 μA Max
- Inputs Are TTL-Voltage Compatible
- Bus-Structured Pinout

description/ordering information

These octal transparent D-type latches feature 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. The 'HCT573 devices are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

While the latch-enable (LE) input is high, the Q outputs respond to the data (D) inputs. When LE is low, the outputs are latched to retain the data that was set up at the D inputs.

A buffered output-enable (\overline{OE}) input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or the high-impedance state. In the high-impedance

	•	,	
OE		U ₂₀] v _{cc}
1D	2	19] 1Q
2D	[] 3	18] 2Q
3D	4	17] 3Q
4D	5	16] 4Q
5D	6	15] 5Q
6D	[7	14] 6Q
7D	8	13] 7Q
8D	9	12] 8Q
GND	[10	11	LE

SN54HCT573 . . . FK PACKAGE (TOP VIEW)

	2D 2D 2D 2C 2D	
0 D		~~
3D	∐ 4 18 ∐	2Q
4D	5 17	3Q
5D	6 16	4Q
3D 4D 5D 6D 7D		5Q
7D	8 14	6Q
	9 10 11 12 13	
	300 200 200 200 200 200 200	

state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without interface or pullup components.

тд	PACKAG	GE†	ORDERABLE PART NUMBER	TOP-SIDE MARKING	
			FART NUMBER	WARKING	
	PDIP – N	Tube	SN74HCT573N	SN74HCT573N	
−40°C to 85°C	SOIC - DW	Tube	SN74HCT573DW	HCT573	
	3010 - 010	Tape and reel	SN74HCT573DWR	пст575	
	SOP – NS	Tape and reel	SN74HCT573NSR	HCT573	
	SSOP – DB	Tape and reel	SN74HCT573DBR	HT573	
	TSSOP – PW	Tube	SN74HCT573PW	HT573	
	1330F - FW	Tape and reel	SN74HCT573PWR		
	CDIP – J	Tube	SNJ54HCT573J	SNJ54HCT573J	
–55°C to 125°C	CFP – W	Tube	SNJ54HCT573W	SNJ54HCT573W	
	LCCC – FK	Tube	SNJ54HCT573FK	SNJ54HCT573FK	

ORDERING INFORMATION

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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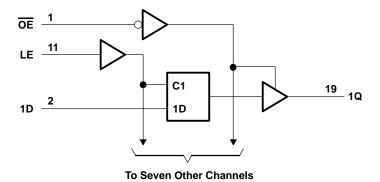
SN54HCT573, SN74HCT573 **OCTAL TRANSPARENT D-TYPE LATCHES** WITH 3-STATE OUTPUTS SCLS176E - MARCH 1984 - REVISED JULY 2003

description/ordering information (continued)

OE does not affect the internal operations of the latches. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

	FUNCTION TABLE (each latch)											
	INPUTS	OUTPUT										
OE	LE	Q										
L	Н	Н	Н									
L	н	L	L									
L	L	Х	Q ₀									
н	Х	Х	z									

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC}	
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$) (see N	Note 1) ±20 mA
Output clamp current, I_{OK} (V _O < 0 or V _O > V _{CC}) (see Note 1) ±20 mA
Continuous output current, $I_O (V_O = 0 \text{ to } V_{CC})$	±35 mA
Continuous current through V _{CC} or GND	±70 mA
Package thermal impedance, θ_{JA} (see Note 2): D	B package
D	N package 58°C/W
Ν	package 69°C/W
N	S package 60°C/W
P	<i>N</i> package
Storage temperature range, T _{stg}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51-7.



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recommended operating conditions (see Note 3)

			SN	54HCT5	i73	SN	74HCT5	73	UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage		4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	V _{CC} = 4.5 V to 5.5 V	2			2			V
VIL	Low-level input voltage	$V_{CC} = 4.5 V \text{ to } 5.5 V$		44	0.8			0.8	V
VI	Input voltage		0	5	VCC	0		VCC	V
Vo	Output voltage		0 🗸	20	VCC	0		VCC	V
$\Delta t/\Delta v$	Input transition rise/fall time		30)	500			500	ns
Т _А	Operating free-air temperature		-55		125	-40		85	°C

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CO	v _{cc}	T _A = 25°C			SN54HCT573		SN74HCT573		UNIT	
PARAMETER	TEST CO		MIN	TYP	MAX	MIN	MAX	MIN	MAX		
Vou	VI = VIH or VIL	I _{OH} = -20 μA	4.5 V	4.4	4.499		4.4		4.4		V
VOH	VI = VIH OL VIL	I _{OH} =6 mA	4.5 V	3.98	4.3		3.7	h	3.84		Ň
Ve	VI = VIH or VIL	I _{OL} = 20 μA	4.5 V		0.001	0.1		0.1		0.1	V
VOL		I _{OL} = 6 mA	4.5 V		0.17	0.26		0.4		0.33	v
l	$V_{I} = V_{CC} \text{ or } 0$		5.5 V		±0.1	±100	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~	±1000		±1000	nA
I _{OZ}	AO = ACC or 0		5.5 V		±0.01	±0.5	202	±10		±5	μA
ICC	$V_{I} = V_{CC} \text{ or } 0,$	l _O = 0	5.5 V			8	201	160		80	μA
∆lcc [†]	One input at 0.5 \ Other inputs at 0	5.5 V		1.4	2.4	Q	3		2.9	mA	
Ci			4.5 V to 5.5 V		3	10		10		10	pF

[†] This is the increase in supply current for each input that is at one of the specified TTL voltage levels, rather than 0 V or V_{CC}.

timing requirements over recommended operating free-air temperature range (unless otherwise noted)

		Vee		T _A = 25°C		SN54HCT573		SN74HCT573	
		Vcc	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
•	Pulse duration, LE high		20		30	VIE	25		ns
t _w			17		27	RE	23		115
			10		15	' /	13		
t _{su}	Setup time, data before LE \downarrow	5.5 V	9		14		12		ns
+.	Hold time, data after LE \downarrow		5		05		5		ns
^t h			5		Q 5		5		



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switching characteristics over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	Vaa	Тд	_ = 25°C	;	SN54HCT573	SN74HCT573	UNIT	
FARAMETER	(INPUT)	(OUTPUT)	Vcc	MIN	TYP	MAX	MIN MAX	MIN MAX	UNIT	
	D	Q	4.5 V		25	35	53	44		
^t pd	D	ý	5.5 V		21	32	48	40	20	
	LE	Any Q	4.5 V		28	35	53	44	ns	
	LL	Ally Q	5.5 V		25	32	48	40		
•	OE	Any Q	4.5 V		26	35	53	44	20	
t _{en}	ÛE	Ally Q	5.5 V		23	32	2 ₂ 2 2 2	40	ns	
t	OE	Any Q	4.5 V		23	35	53	44	200	
^t dis	ÛE	Ally Q	5.5 V		22	32	48	40	ns	
+.		Any Q	4.5 V		9	12	18	15	ns	
tt			5.5 V		9	11	16	14	115	

switching characteristics over recommended operating free-air temperature range, $C_L = 150 \text{ pF}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	Vee	Т	₄ = 25°C	;	SN54HCT573	SN74HCT573	UNIT	
PARAMETER	(INPUT)	(OUTPUT)	Vcc	MIN	TYP	MAX	MIN MAX	MIN MAX		
	D	Q	4.5 V		32	52	79	65		
.	U	Ŷ	5.5 V		27	47	71	59	-	
^t pd	LE	Any Q	4.5 V		38	52	79	65	ns	
	LL	Any Q	5.5 V		36	47	Q 71	59		
+	OE	Any Q	4.5 V		33	52	O 79	65	ns	
^t en	ÛE	Any Q	5.5 V		28	47	Q 71	59	115	
+.			4.5 V		18	42	63	53	20	
tt		Any Q	5.5 V		16	38	57	48	ns	

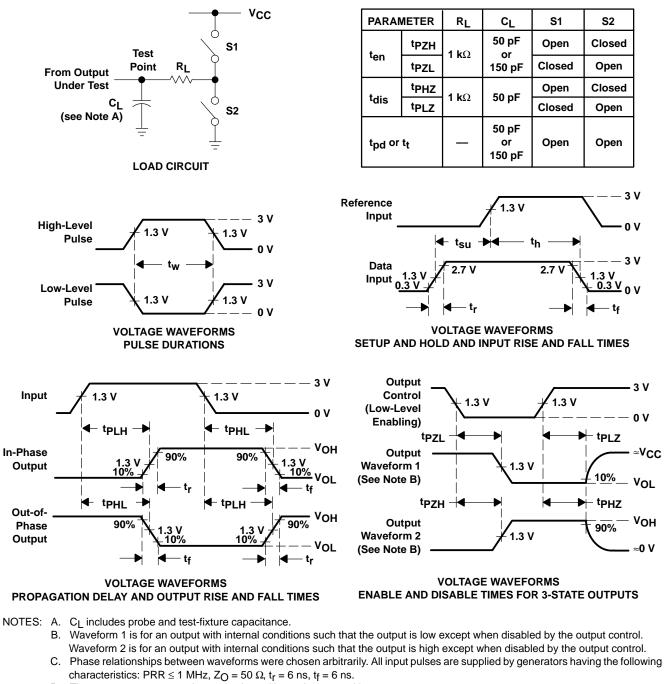
operating characteristics, $T_A = 25^{\circ}C$

	PARAMETER	TEST CONDITIONS	TYP	UNIT
C _{pd}	Power dissipation capacitance per latch	No load	50	pF



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PARAMETER MEASUREMENT INFORMATION



- D. The outputs are measured one at a time with one input transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- F. tp₇ and tp₇ are the same as t_{en} .
- G. tPLH and tPHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms





24-Apr-2015

PACKAGING INFORMATION

Orderable Device	Status	Package Type	•	Pins	•	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
SN74HCT573DBR	ACTIVE	SSOP	DB	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HT573	Samples
SN74HCT573DBRG4	ACTIVE	SSOP	DB	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HT573	Samples
SN74HCT573DW	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HCT573	Samples
SN74HCT573DWG4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HCT573	Samples
SN74HCT573DWR	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HCT573	Samples
SN74HCT573DWRE4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HCT573	Samples
SN74HCT573DWRG4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HCT573	Samples
SN74HCT573N	ACTIVE	PDIP	Ν	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-40 to 85	SN74HCT573N	Samples
SN74HCT573N3	OBSOLETE	PDIP	N	20		TBD	Call TI	Call TI	-40 to 85		
SN74HCT573NSR	ACTIVE	SO	NS	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HCT573	Samples
SN74HCT573NSRE4	ACTIVE	SO	NS	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HCT573	Samples
SN74HCT573PW	ACTIVE	TSSOP	PW	20	70	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HT573	Samples
SN74HCT573PWG4	ACTIVE	TSSOP	PW	20	70	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HT573	Samples
SN74HCT573PWR	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HT573	Samples
SN74HCT573PWRE4	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HT573	Samples
SN74HCT573PWRG4	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HT573	Samples

(1) The marketing status values are defined as follows:
 ACTIVE: Product device recommended for new designs.
 LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

PACKAGE OPTION ADDENDUM



www.ti.com

24-Apr-2015

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design. **PREVIEW:** Device has been announced but is not in production. Samples may or may not be available. **OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



All dimensions are nominal Device	1	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74HCT573DBR	SSOP	DB	20	2000	330.0	16.4	8.2	7.5	2.5	12.0	16.0	Q1
SN74HCT573DWR	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
SN74HCT573NSR	SO	NS	20	2000	330.0	24.4	9.0	13.0	2.4	4.0	24.0	Q1
SN74HCT573PWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1

TEXAS INSTRUMENTS

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PACKAGE MATERIALS INFORMATION

24-Apr-2015



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74HCT573DBR	SSOP	DB	20	2000	367.0	367.0	38.0
SN74HCT573DWR	SOIC	DW	20	2000	367.0	367.0	45.0
SN74HCT573NSR	SO	NS	20	2000	367.0	367.0	45.0
SN74HCT573PWR	TSSOP	PW	20	2000	367.0	367.0	38.0

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- \triangle The 20 pin end lead shoulder width is a vendor option, either half or full width.



DW (R-PDSO-G20)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

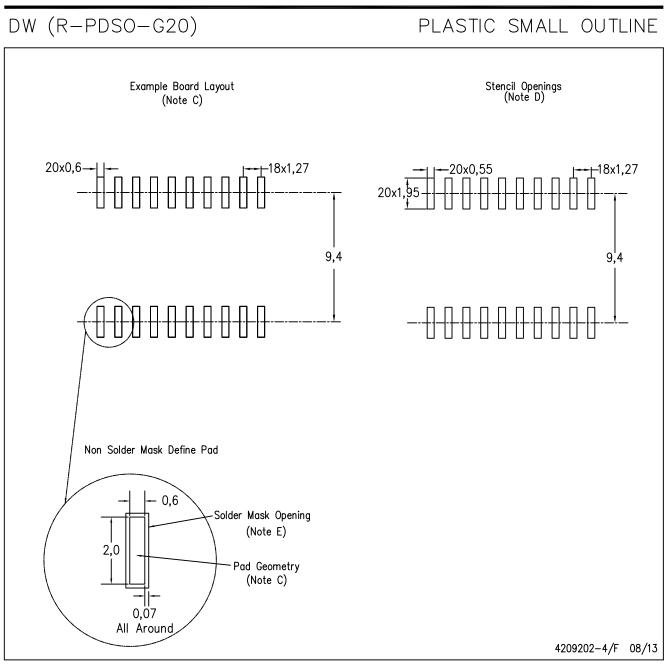
B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AC.



LAND PATTERN DATA



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Refer to IPC7351 for alternate board design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



PW (R-PDSO-G20)

PLASTIC SMALL OUTLINE



NOTES:

A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994. β . This drawing is subject to change without notice.

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.

Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.

E. Falls within JEDEC MO-153



LAND PATTERN DATA



NOTES: Α. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
 C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



MECHANICAL DATA

MSSO002E - JANUARY 1995 - REVISED DECEMBER 2001

DB (R-PDSO-G**)

PLASTIC SMALL-OUTLINE

28 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-150



MECHANICAL DATA

PLASTIC SMALL-OUTLINE PACKAGE

0,51 0,35 ⊕0,25⊛ 1,27 8 14 0,15 NOM 5,60 8,20 5,00 7,40 \bigcirc Gage Plane ₽ 0,25 7 1 1,05 0,55 0°-10° Δ 0,15 0,05 Seating Plane — 2,00 MAX 0,10PINS ** 14 16 20 24 DIM 10,50 10,50 12,90 15,30 A MAX A MIN 9,90 9,90 12,30 14,70 4040062/C 03/03

NOTES: A. All linear dimensions are in millimeters.

NS (R-PDSO-G**)

14-PINS SHOWN

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



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Power Mgmt	power.ti.com	Space, Avionics and Defense	www.ti.com/space-avionics-defense			
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RFID	www.ti-rfid.com					
OMAP Applications Processors	www.ti.com/omap	TI E2E Community	e2e.ti.com			
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